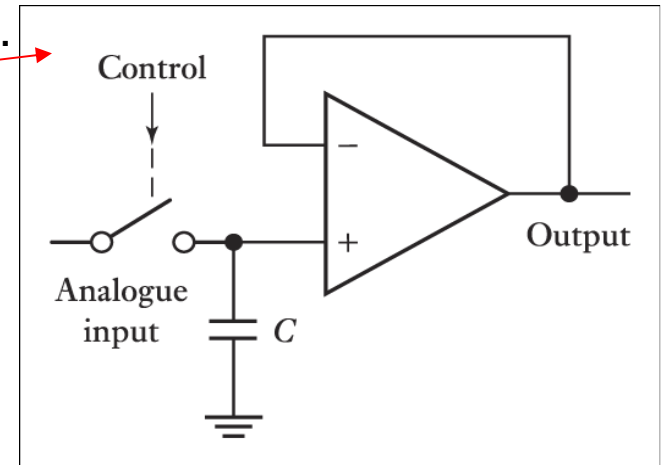
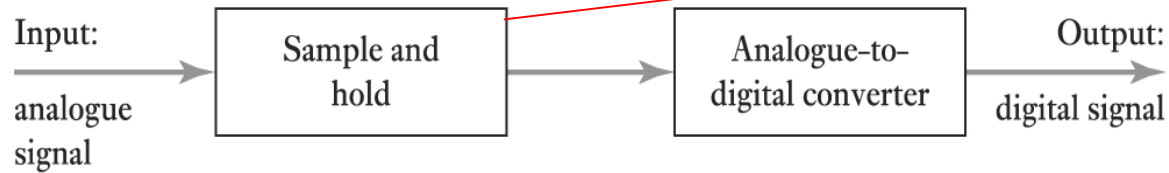


Analog to Digital Conversion

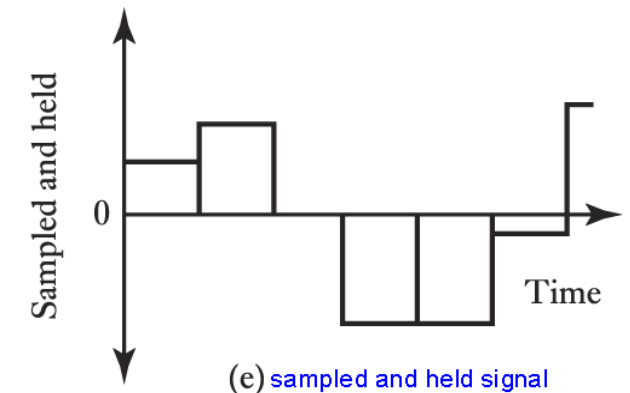
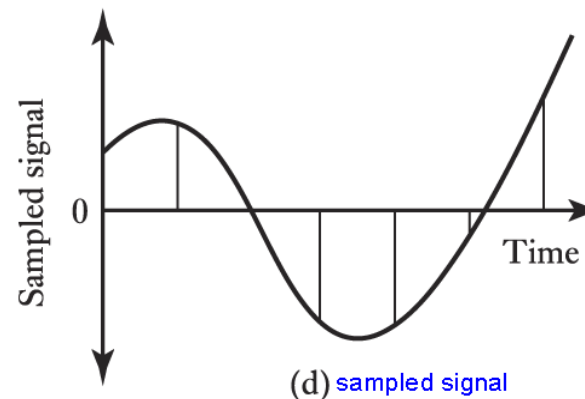
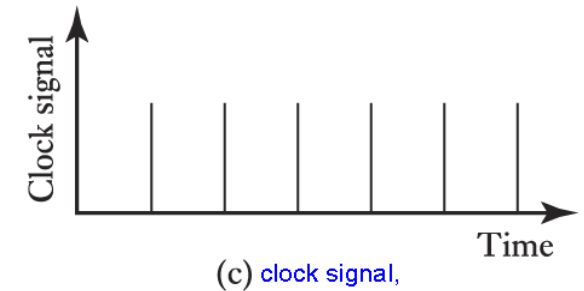
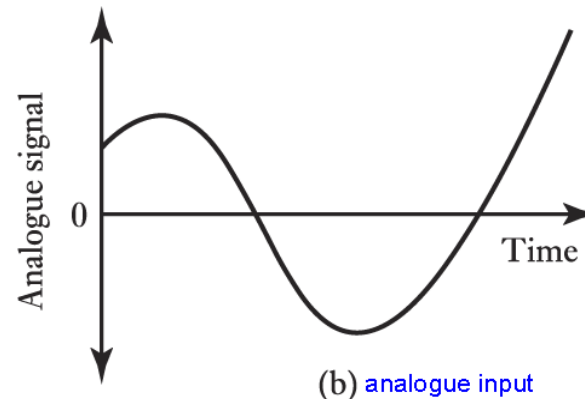
Involves converting the analogue signals into binary words.
The basic elements of ADC is shown below:



A clock supplies regular signal pulses to the ADC and every time it receives a pulse it samples the analogue signal

A sample and hold unit is used to hold each sampled value until the next pulse occurs. The S/H unit is necessary because the AD converter requires a finite amount of time termed the conversion time, to convert the analogue signal into a digital one

Quantization time $\approx 4\mu\text{S}$



AD Conversion

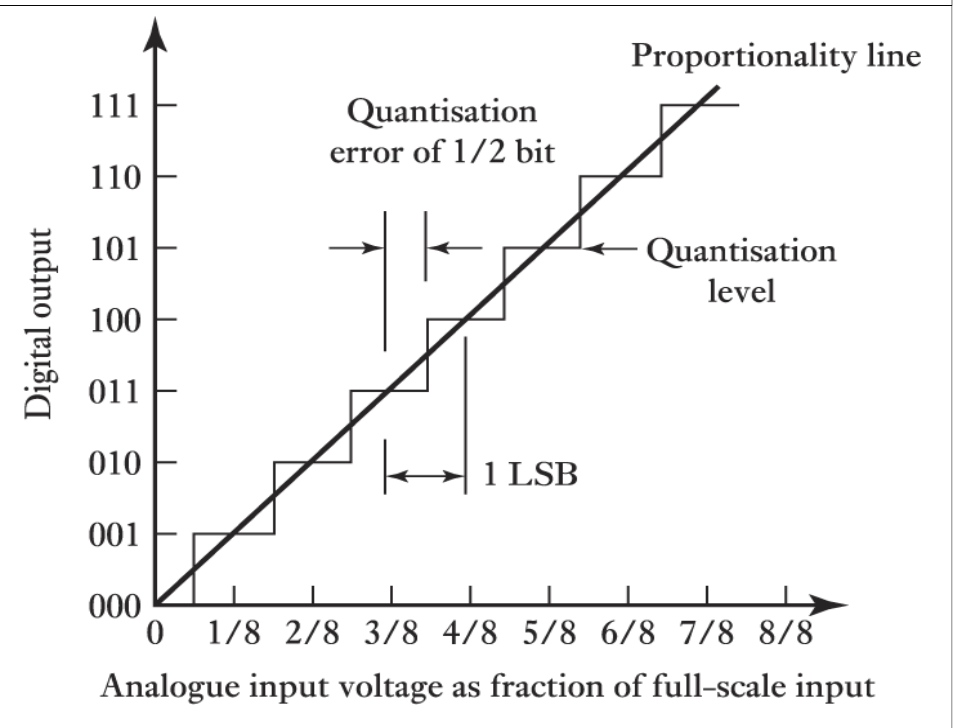
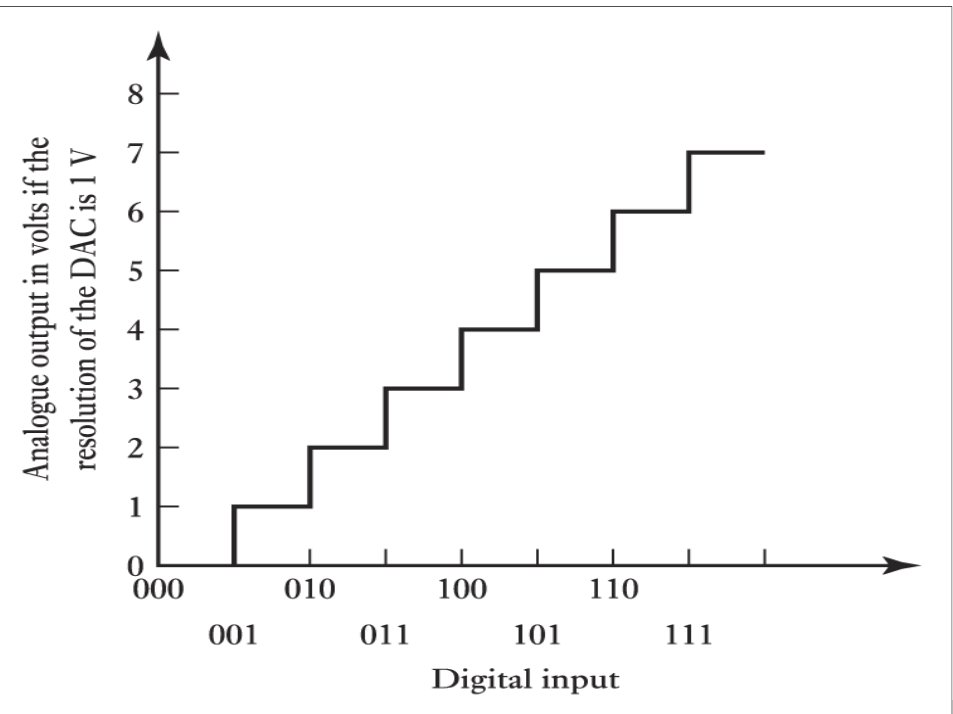
Consider an ADC of 3 bit word then:

The possible output levels is $2^3= 8$ output levels, there is a range of output for which the input does not change.

The 8 possible output levels are termed **quantization level**.

The difference in analogue voltage between two adjacent levels is termed **quantization interval** (=1 volt in Fig.; step like nature)

The digital output is not always equal to the analogue input value and thus there will be an error termed **quantization error**. When the input is centered over the interval, the quantization error is zero. The maximum error being equal to $\frac{1}{2}$ of interval or $\pm\frac{1}{2}$ bit



Analog to Digital Conversion

- The word length determine the resolution of the element:
- **Resolution**= $V_{FS}/2^n$ is the smallest input value which can produce 1 bit change in the output.
- Eg. An ADC has 10 bits and the analogue signal input range is 10 V. The resolution is $10/1024=9.8\text{mV}$

Example: consider a thermocouple giving an output of 0.5 mV/C. What will be the word length required when its output passes through ADC; if temperature of 0-200 °C are to be measured with a resolution of 0.5 °C.

Solution:

Full scale output voltage= $200 \times 0.5 = 100$ mV

With a word length of n bit this voltage will be divided into $100/2^n$ mV steps.

For a resolution of 0.5 °C we must be able to detect a signal from the sensor of:

$$0.5 \times 0.5 = 0.25 \text{ mV}$$

$\therefore 0.25 = 100/2^n \rightarrow n = 8.6$ thus 9 bit word length is required

Sampling theorem (1)

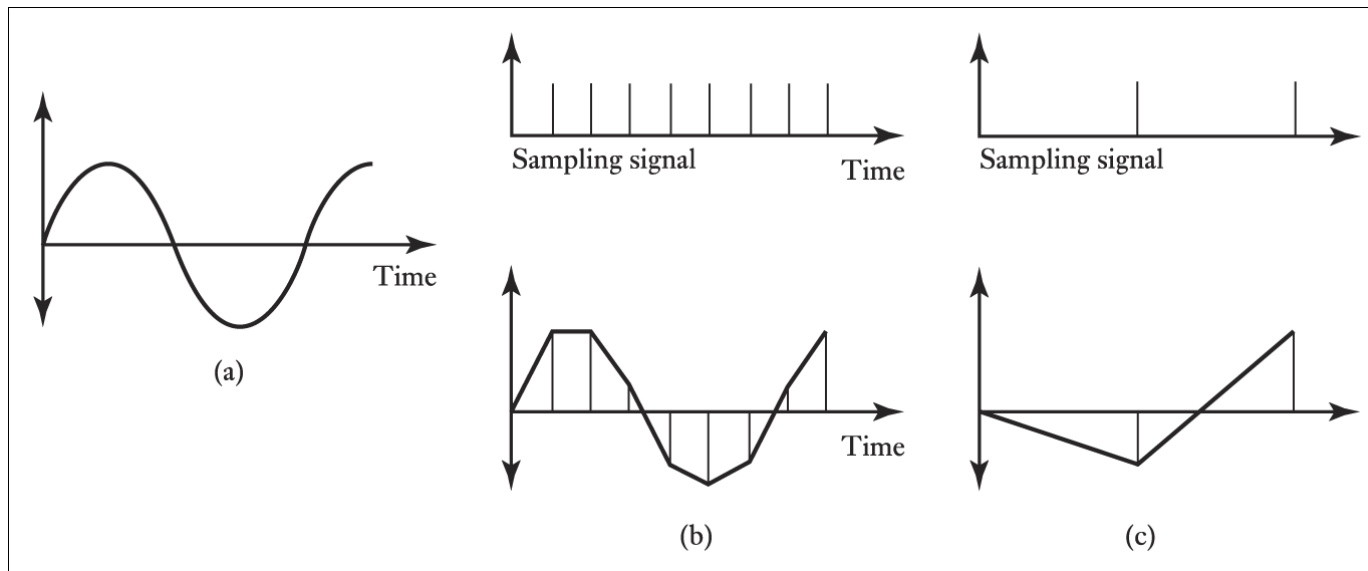
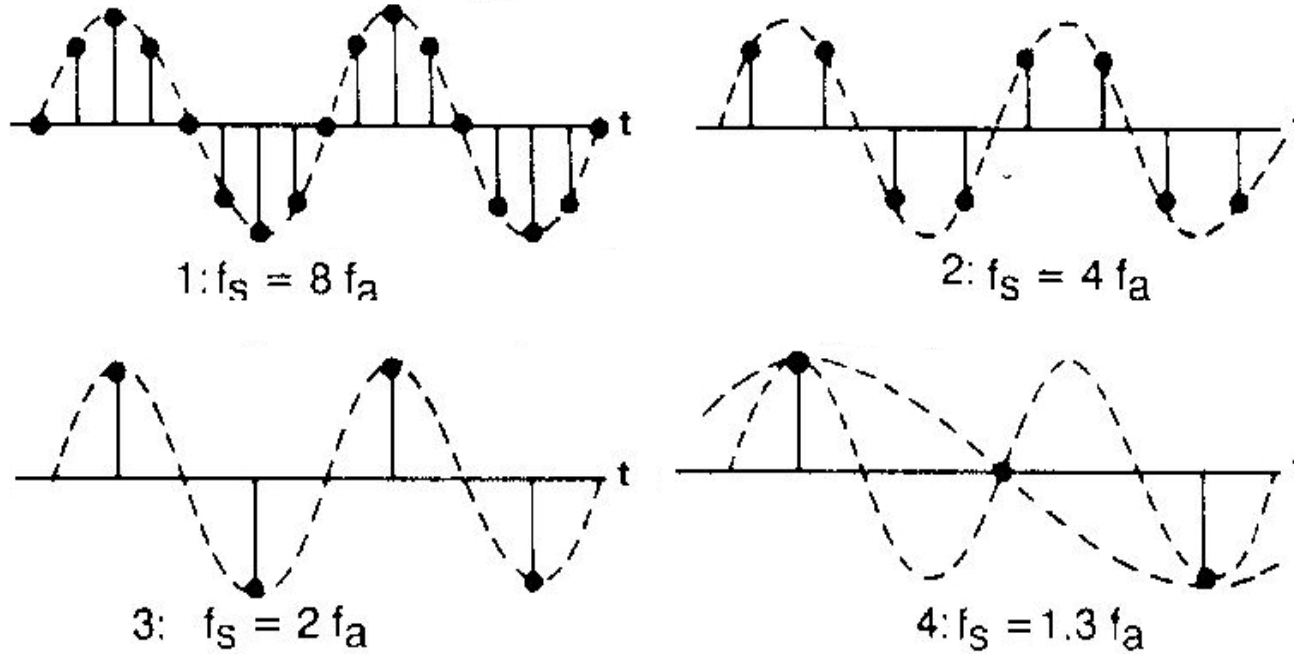
- Nyquist's Criteria or Shannon's theorem
 - An Analog signal with a highest frequency of f_a **MUST** be sampled at a rate $f_s > 2f_a$ to avoid loss of information.
 - If $f_s < 2f_a$ then a phenomena called aliasing will occur in the analog signal bandwidth

Aliasing: When the sampling rate is less than twice the highest frequency, the reconstruction can represent some other analogue signal and we obtain a false image.

An anti-aliasing filter is used precede the ADC, the filter having a band width such that it passes only low frequencies for which sampling rate will not give aliasing errors

Sampling theorem (2)

Aliasing examples:



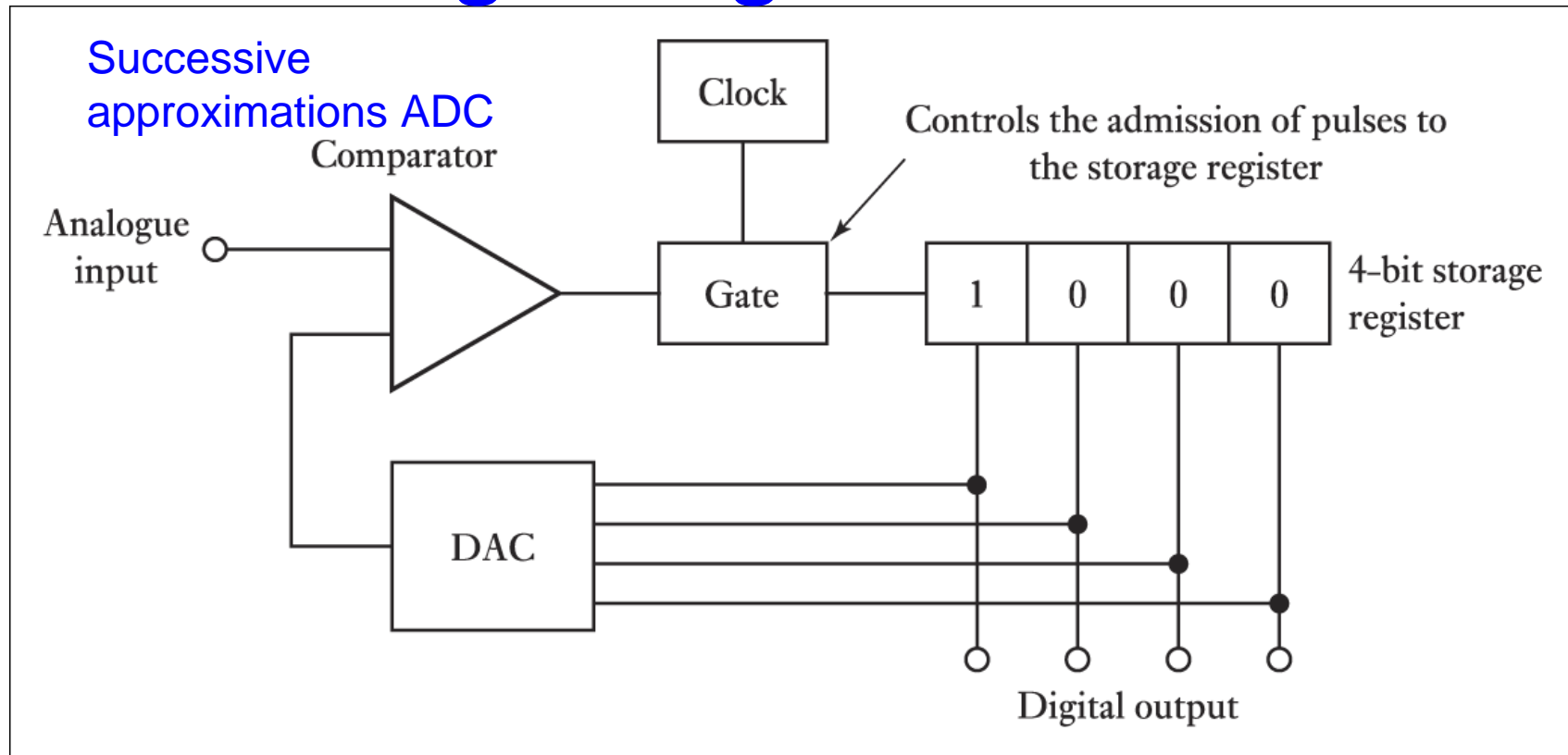
Analog to Digital Converter

- Types:
 - Successive approximate
 - Ramp ADC /Dual Ramp
 - Flash

ADC	Type	Resolution (bits)	Conversion time (ns)	Linearity error (LSB)
ZN439	SA	8	5 000	$\pm 1/2$
ZN448E	SA	8	9 000	$\pm 1/2$
ADS7806	SA	12	20 000	$\pm 1/2$
ADS7078C	SA	16	20 000	$\pm 1/2$
ADC302	F	8	20	$\pm 1/2$

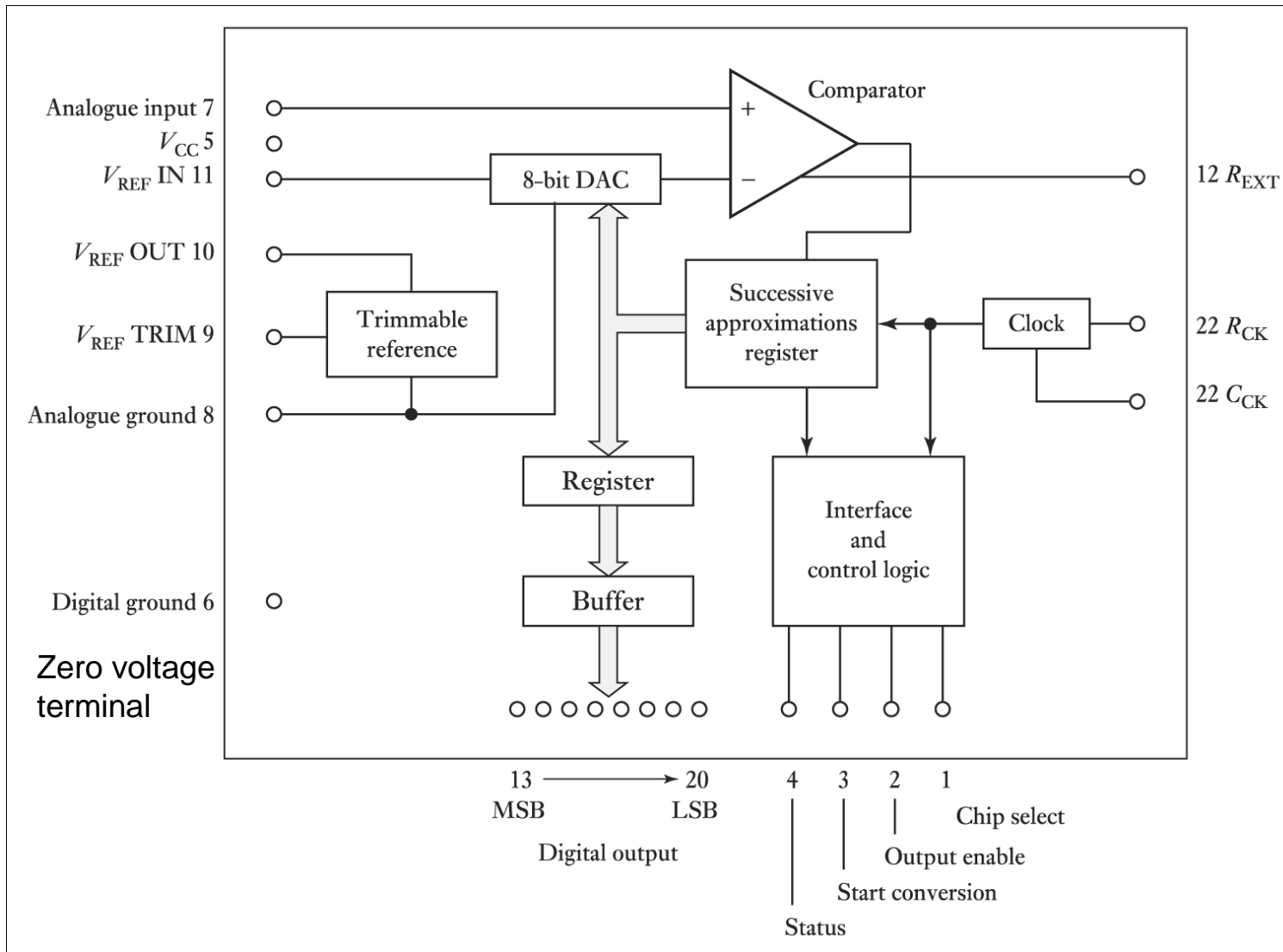
SA = successive approximations, F = flash.

Analog to Digital Converter



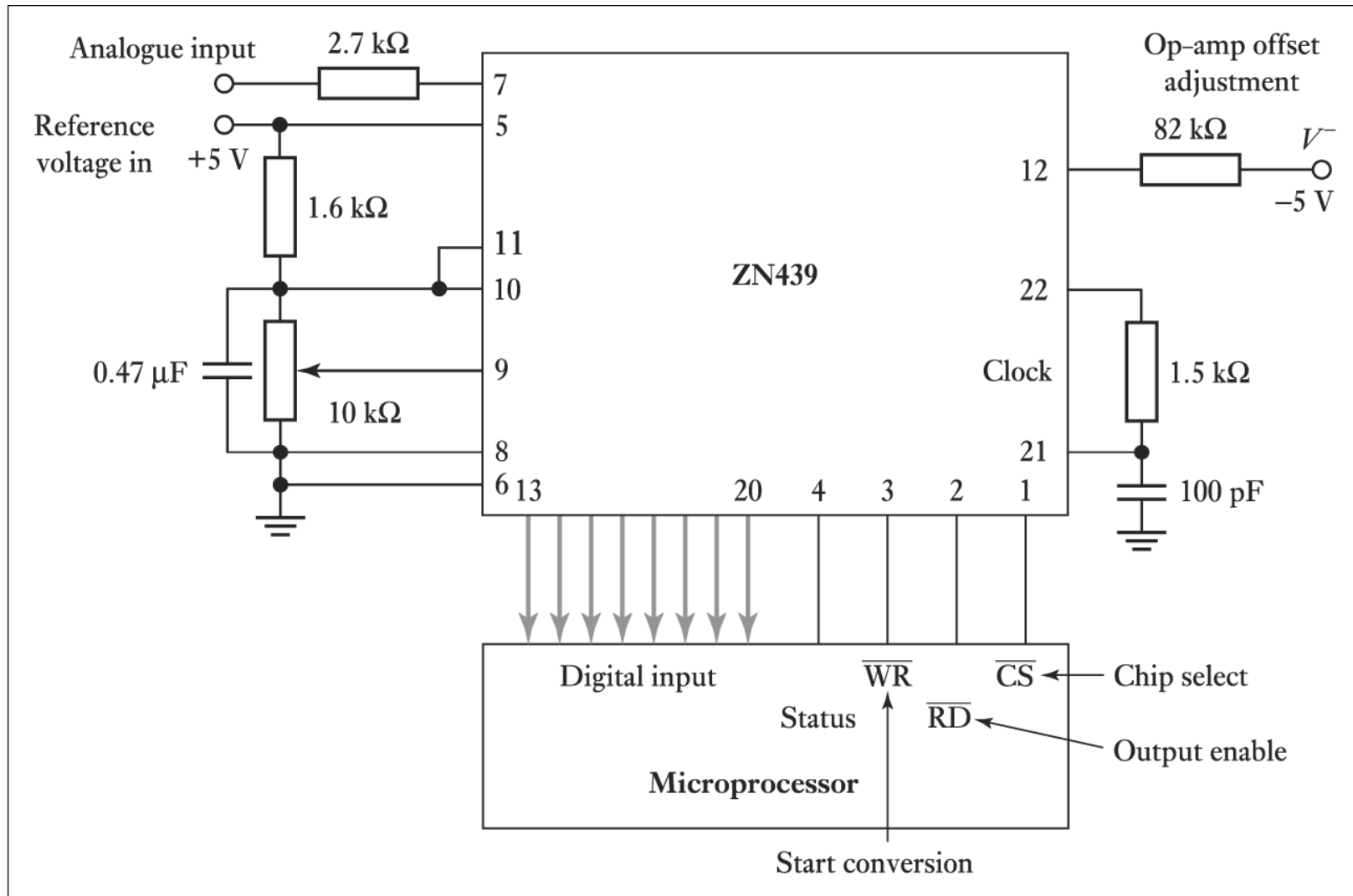
Successive approximations ADC is the most commonly used method. A voltage is generated by a clock emitting a regular sequence of pulses which are counted in binary manner, and the resulting word converted into an analogue voltage by DAC. This voltage rises in step and is compared with the analogue input voltage from the sensor. When the generated voltage passes the input sensor voltage, the pulses from the clock are stopped. The output from the counter at that time is the digital representation of the analogue voltage. Faster successive method is also possible

Analog to Digital Converter



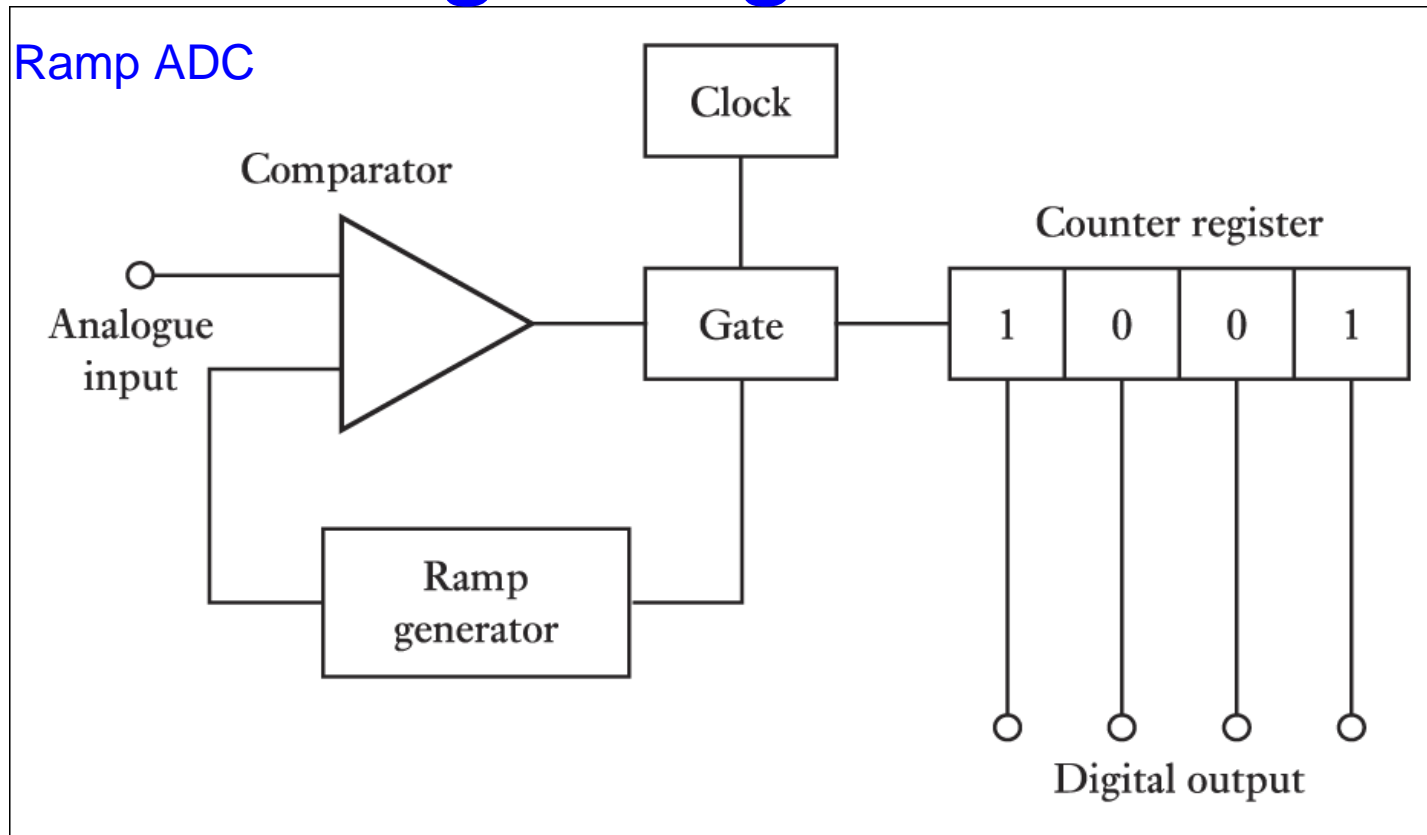
Successive approximations ZN439 ADC outlines

Analog to Digital Converter



Successive approximations ADC ZN439 connected to a microprocessor

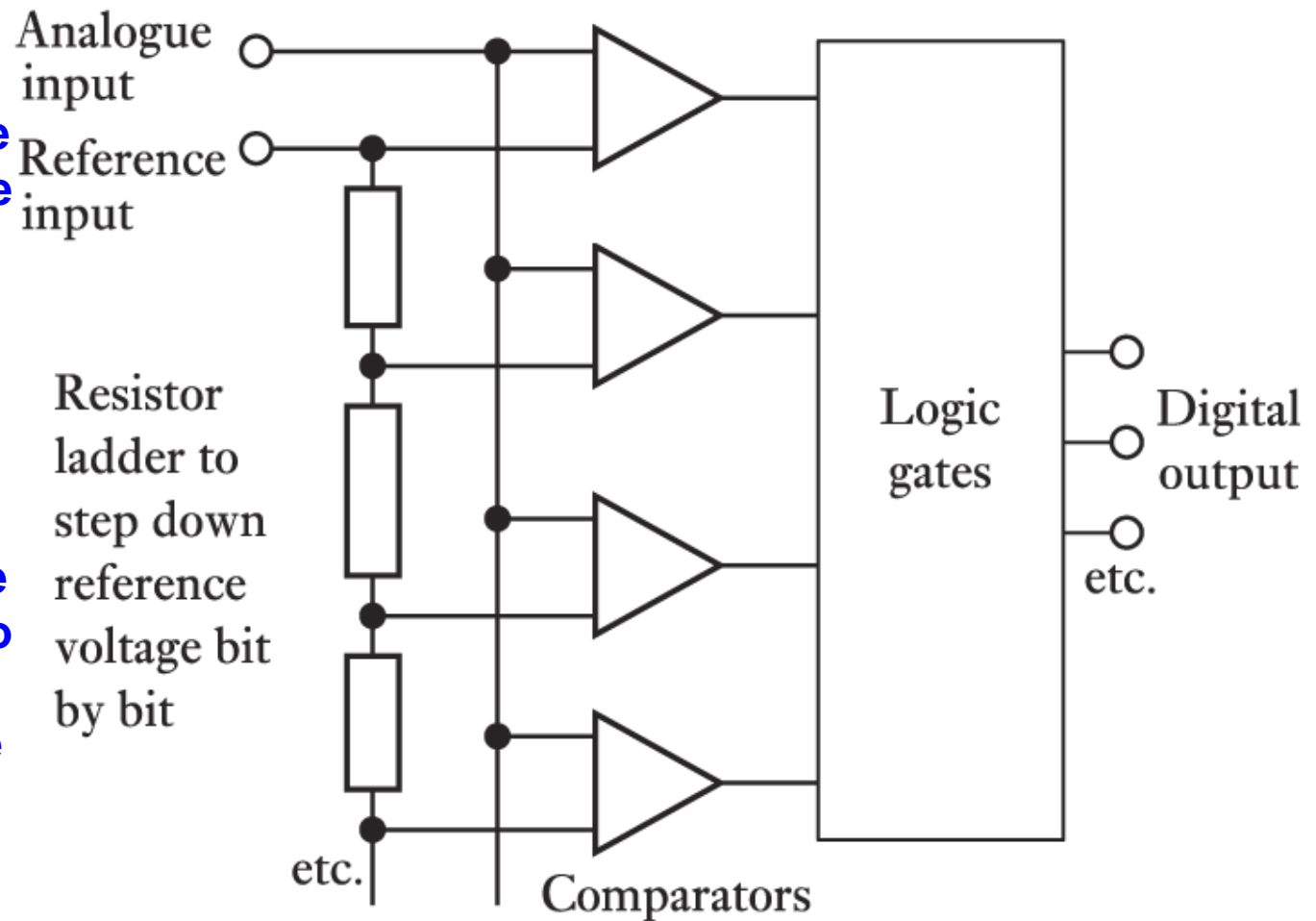
Analog to Digital Converter



Ramp ADC: Involve an analogue voltage which is increased at a constant rate, and applied to a comparator, where it is compared with analogue sensor voltage. When the ramp voltage starts, a gate is opened which starts a binary counter counting the regular pulses from the clock. When the two voltages are equal, the clock stop counting and the counter value indicate the equivalent digital value of the sampled one

AD Flash Converter

Flash ADC is very fast type of ADC .For n bit converter, $2^n - 1$ separate voltage comparators are used in parallel, with each having the analogue input voltage as one input. The reference voltage is applied to a ladder of resistors, so the voltage applied as other input to each comparator is one bit large in size than the voltage applied to the previous comparator in the ladder



Thus when the analogue voltage is applied to ADC, all those comparator for which the analogue voltage is greater than the reference voltage will give a high output and those below the reference will give a low output. The resulting output are fed in parallel to a logic gate system which translate them into a digital word

Digital to Analogue Conversion

A digital-to-analog converter (DAC) is a circuit that produces an analog current or voltage that is proportional to an analog reference (voltage or current) and an N-bit binary word.

$$V_{\text{out}} = k \times V_{\text{ref}} \times (\text{Binary Word})$$

Types of DAC:

Weighted resistor network

R-2R ladder DAC

DAC Binary Weighted Principles

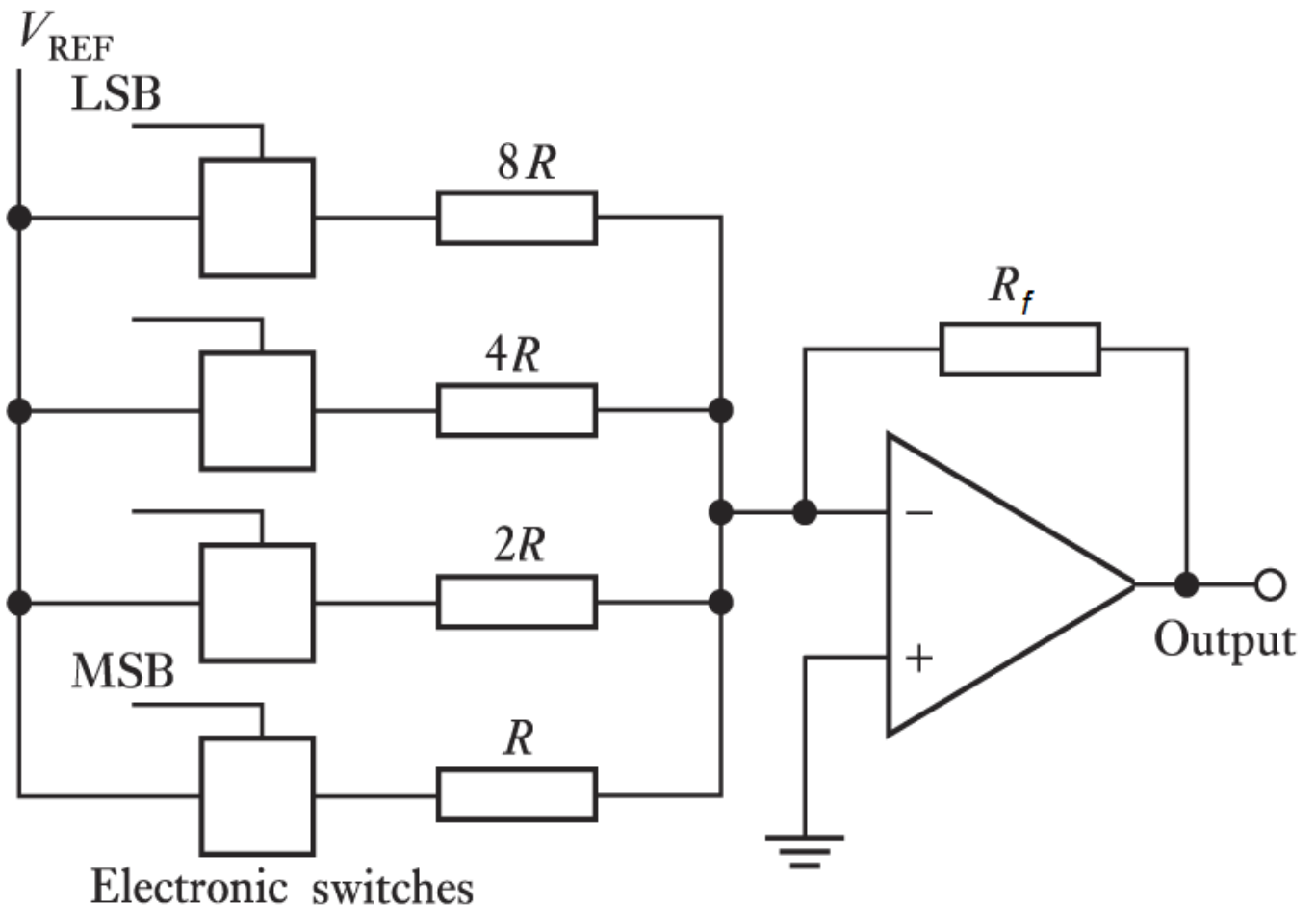
$$I_0 = -\frac{V_{REF}}{R} \left[\frac{b_0}{2^{n-1}} + \frac{b_1}{2^{n-2}} \dots \frac{b_{n-2}}{2^1} + \frac{b_{n-1}}{2^0} \right] \Rightarrow V_{out} = -I_0 R_f$$

I_0 = sum of currents leaving the junction

R = resistance to LSB

n = number of input bits

b = bit status (1=ON or 0=OFF)



DAC Example

Find output voltage and current for a binary weighted resistor DAC of 4 bits where

$R = 10 \text{ k Ohms}$, $R_f = 5 \text{ k Ohms}$ and $V_{\text{ref}} = 10 \text{ Volts}$. Applied binary word is 1001.

Solution:

$$I_o = -\frac{10V}{10k\Omega} \left[\frac{1}{2^0} + \frac{0}{2^1} + \frac{0}{2^2} + \frac{1}{2^3} \right]$$

$$I_o = -0.001125 \text{ A}$$

$$V_o = -R_f I_o$$

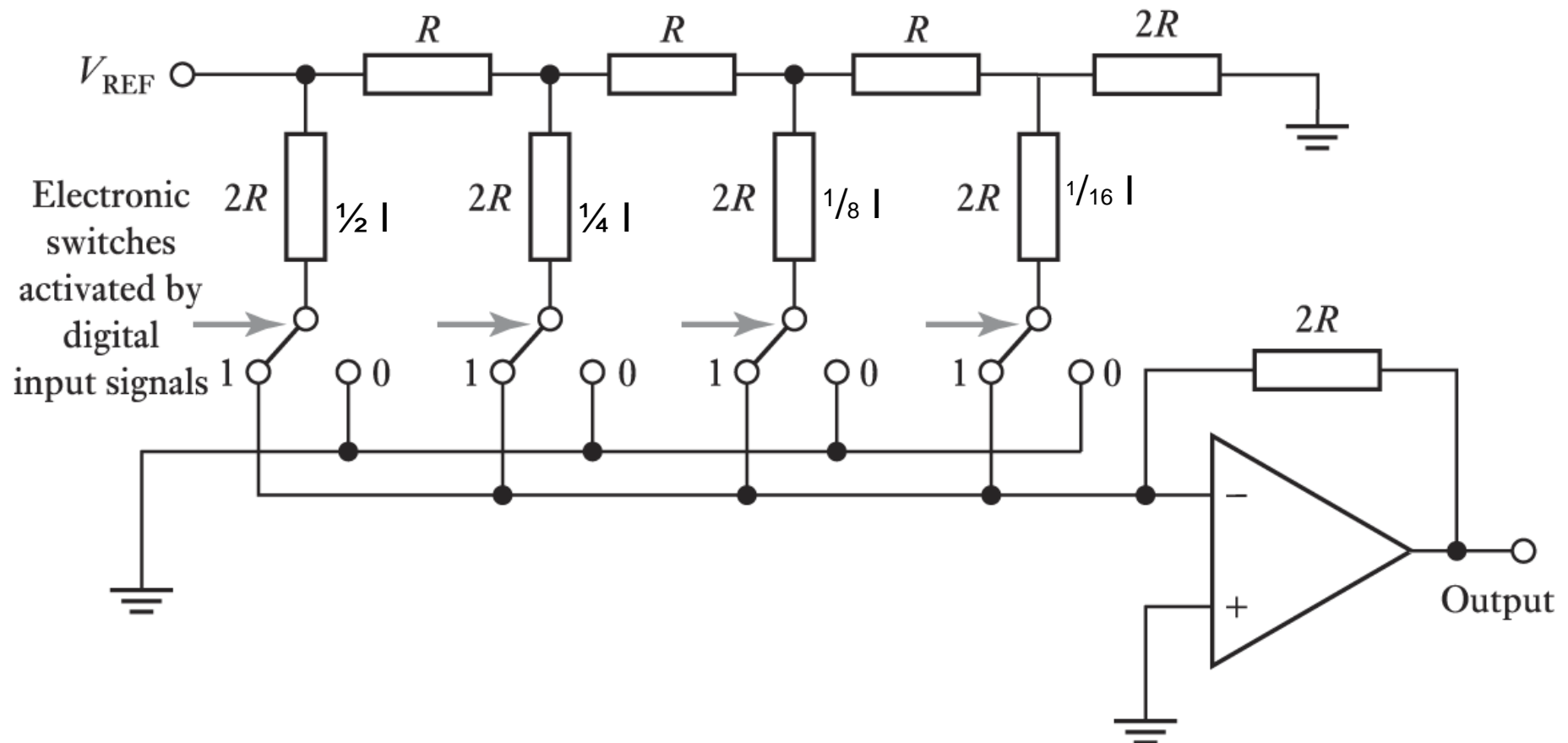
$$V_o = -(5k\Omega)(-0.001125A) = 5.625V$$

Limitations of the Binary Weighted DAC

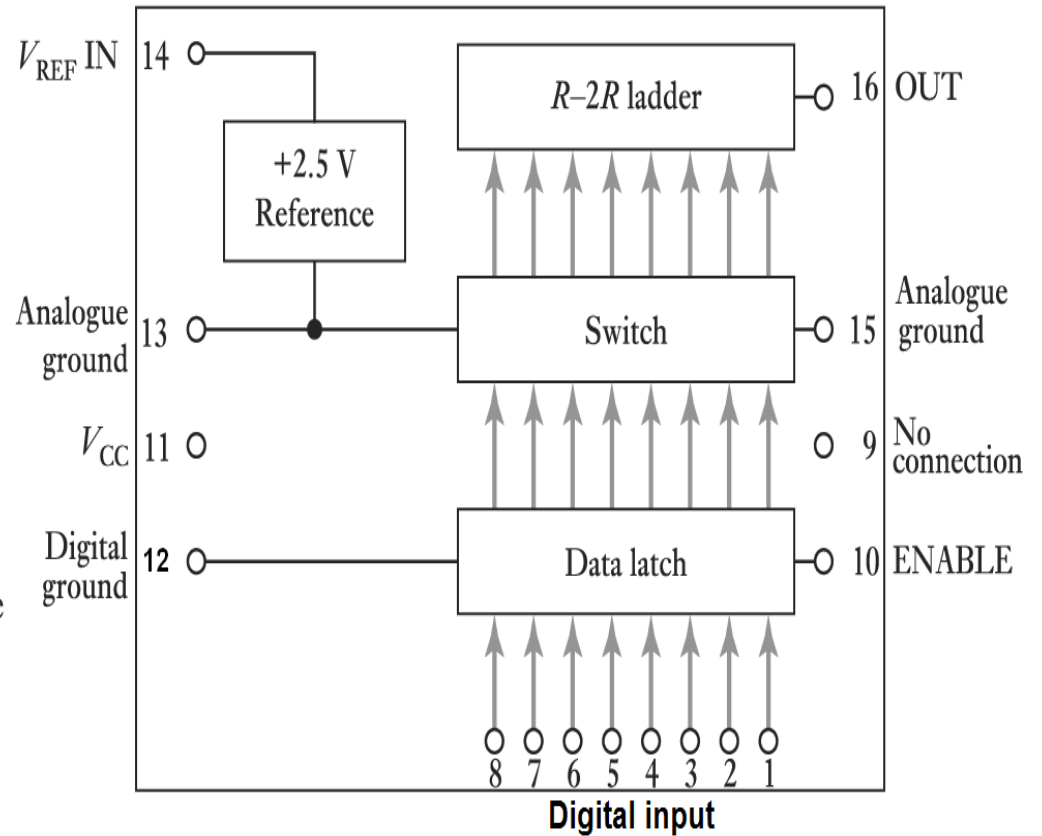
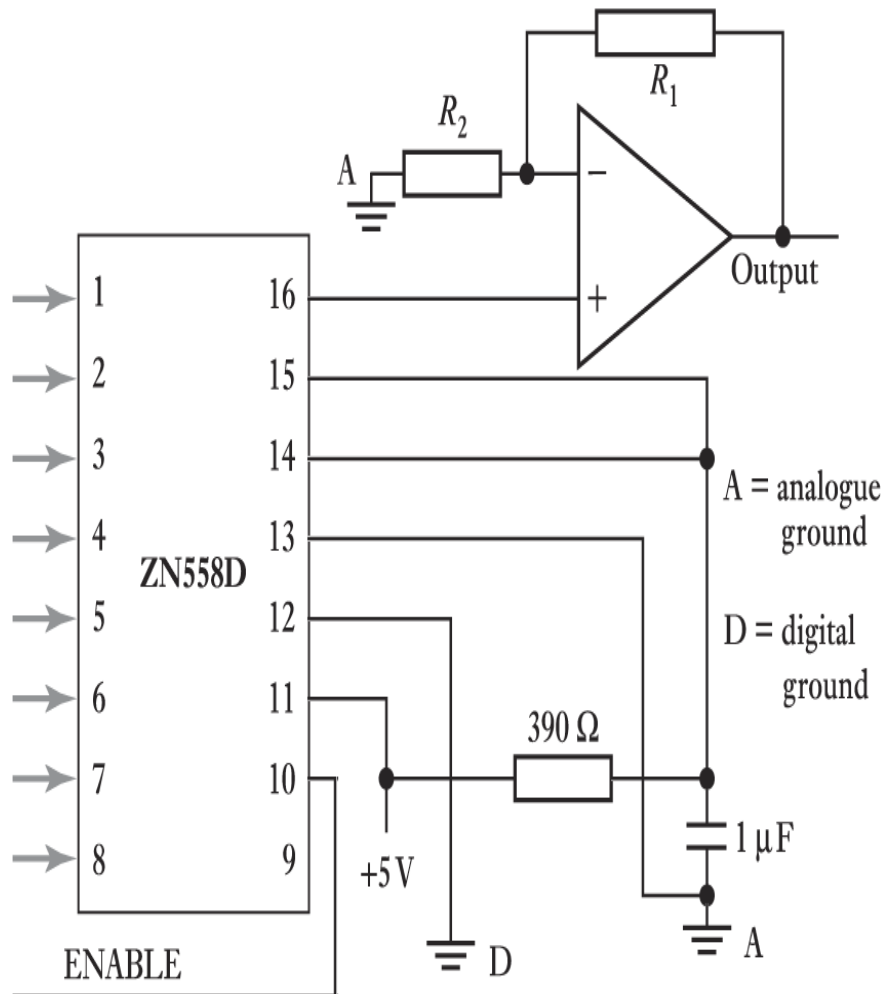
- A problem with the weighted resistor network is that accurate resistances have to be used for each of the resistors and its difficult to obtain such resistors over the wide range needed. As a result this form of DAC is limited to 4 bit conversion
- So normally a ladder **R-2R** circuit which required only two accurate resistor value is used to overcome such problem

$R-2R$ ladder DAC

More commonly used, only two values of resistors are required. The output is generated by switching the weighted reference voltage either to the **-ive** input terminal of the opamp or to the earth terminal depending on the value of the digital input binary value (0 or 1)



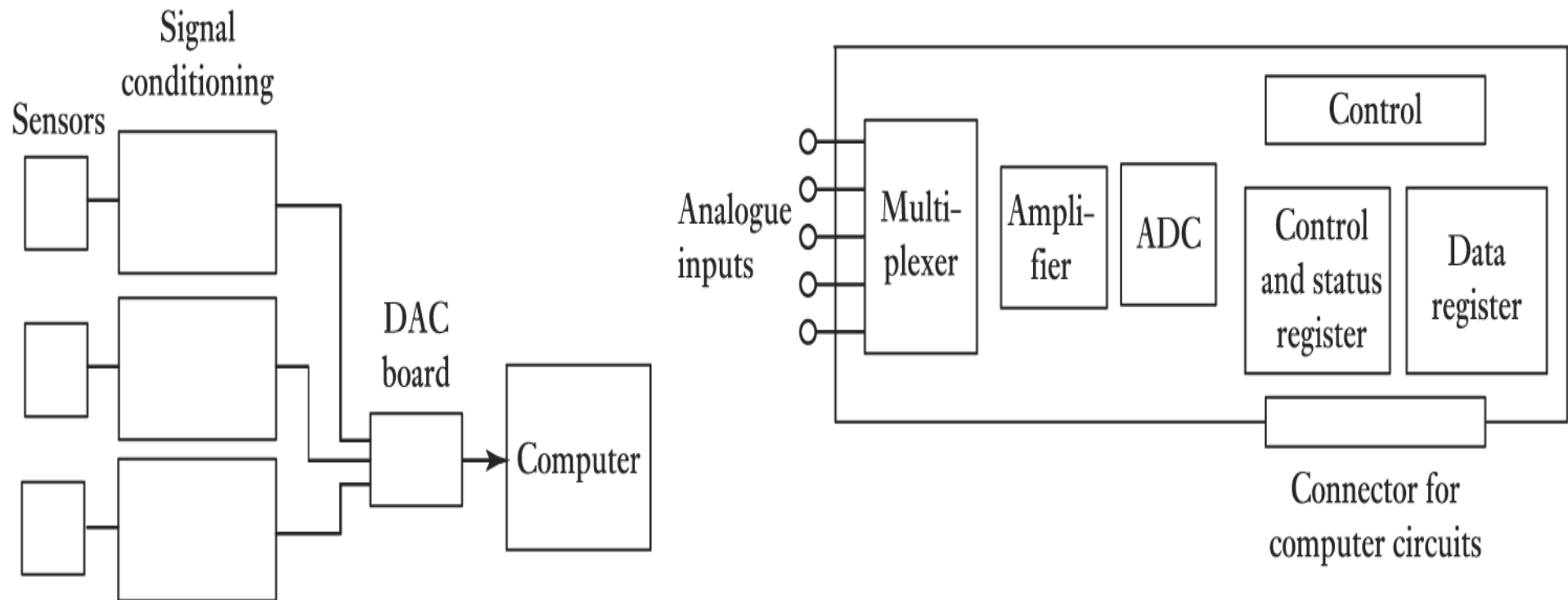
DAC structure ZN558D



DATA ACQUISITION System (DAQ)

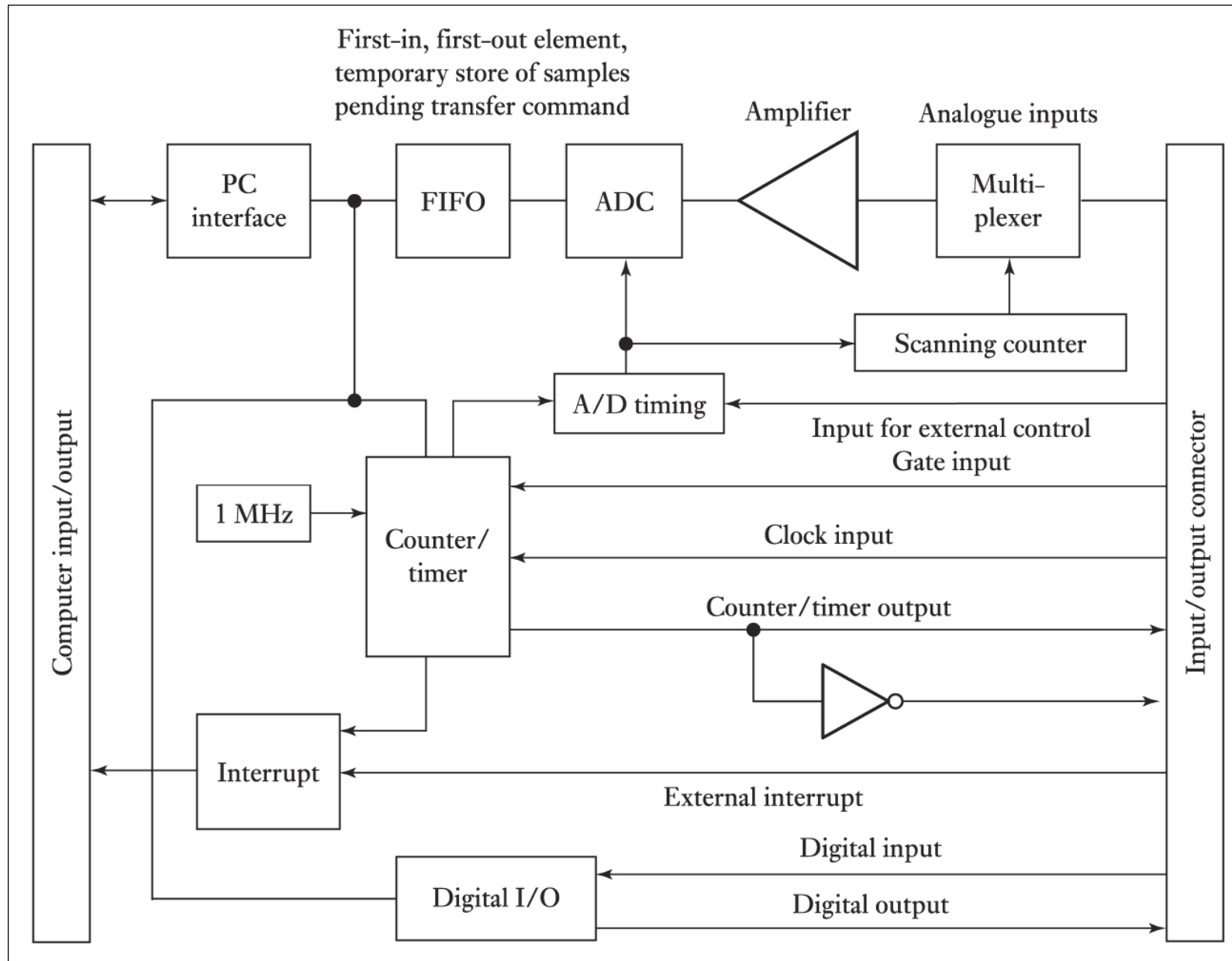
The term DAQ is used for the process of taking data from sensors and inputting that data into a computer for processing.

The basic elements of the DAQ Board is shown below:



Computer software is used to control the acquisition of data via DAQ board

Typical DAQ Board



PC-LPM-16 DAQ board